

MOSFET - Power, N-Channel, PowerTrench[®] Power Clip, Symmetric Dual 30 V NTTFD2D8N03P1E

Features

- Small Footprint (3.3mm x 3.3mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- These Devices are Pb-Free and are RoHS Compliant

Typical Applications

- DC-DC Converters
- System Voltage Rails

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

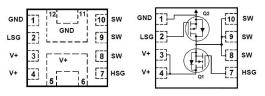
Parameter			Symbol	Q1	Q2	Unit
Drain-to-Source Voltage			V _{DSS}	30	30	٧
Gate-to-Source Volta	Gate-to-Source Voltage			+16 -12	+16 -12	V
Continuous Drain Current R _{AJC}		T _C = 25°C	I _D	80	80	Α
(Note 3)	Steady	T _C = 85°C		58	58	
Power Dissipation R _{θJC} (Note 3)	State	T _A = 25°C	P _D	26	26	W
Continuous Drain		T _A = 25°C	I _D	21.1	21.1	Α
Current R _{θJA} (Notes 1, 3)	Steady	T _A = 85°C		15.2	15.2	
Power Dissipation R _{0JA} (Notes 1, 3)	State	T _A = 25°C	P _D	1.79	1.79	W
Continuous Drain		T _A = 25°C	I _D	16.1	16.1	Α
Current R _{θJA} (Notes 2, 3)	Steady	T _A = 85°C		11.6	11.6	
Power Dissipation R _{0JA} (Notes 2, 3)	State	T _A = 25°C	P _D	1.04	1.04	W
Pulsed Drain Current	$T_A = 25^{\circ}$	C, t _p = 10 μs	I _{DM}	327	356	Α
Single Pulse Drain-to-Source Avalanche Energy Q1: I _L = 33.3 A _{pk} , L = 0.1 mH (Note 4) Q2: I _L = 34.3 A _{pk} , L = 0.1 mH (Note 4)			E _{AS}	55.4	58.8	mJ
Operating Junction and Storage Temperature			T _J , T _{stg}	-55 to	+ 150	°C
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	26	30	°C

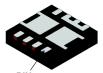
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Surface-mounted on FR4 board using a 1 in² pad size, 2 oz. Cu pad.
- 2. Surface-mounted on FR4 board using minimum pad size, 2 oz. Cu pad.
- 3. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted. Actual continuous current will be limited by thermal & electro–mechanical application board design. $R_{\theta,JC}$ is determined by the user's board design.
- Q1 100% UIS tested at L = 0.1 mH, IAS = 21.1 A.
 Q2 100% UIS tested at L = 0.1 mH, IAS = 21.1 A.
- 5. This device is Class 1B ESD HBM Rating.

FET	V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
Q1	30 V	2.5 m Ω @ 10 V	80 A
Q i	30 V	3.0 m Ω @ 4.5 V	60 A
Q2	30 V	2.5 m Ω @ 10 V	80 A
Υ 2	30 V	3.0 m Ω @ 4.5 V	60 A

ELECTRICAL CONNECTION





WQFN12 3.3X3.3, 0.65P CASE 510CJ

MARKING DIAGRAM



3ESN = Specific Device Code A = Assembly Location

Y = Year
WW = Work Week
ZZ = Assembly Lot Code

ORDERING INFORMATION

Device	Package	Shipping [†]
NTTFD2D8N03P1E	WQFN12 (Pb-Free)	3000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Q1 Max	Q2 Max	Unit
Junction-to-Case - Steady State (Notes 1, 3)	$R_{ heta JC}$	4.8	4.8	°C/W
Junction-to-Ambient - Steady State (Notes 1, 3)	$R_{ hetaJA}$	70	70	
Junction-to-Ambient - Steady State (Notes 2, 3)	$R_{ heta JA}$	120	120	

ELECTRICAL CHARACTERISTICS /T

Parameter	Symbol	Test Condition	FET	Min	Тур	Max	Unit
OFF CHARACTERISTICS	<u> </u>						
Drain-to-Source Breakdown	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$		30			.,
Voltage		$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	Q2	30			V
Drain-to-Source Breakdown	V _{(BR)DSS} /	I _D = 1 mA, ref to 25°C			17.9		1400
Voltage Temperature Coefficient	TJ	I _D = 1 mA, ref to 25°C			17.2		mV/°C
Zero Gate Voltage Drain Current	I_{DSS} $V_{GS} = 0 V$,	$V_{GS} = 0 \text{ V},$ $T_{J} = 25^{\circ}\text{C}$	T _J = 25°C Q1			1.0	
		V _{DS} = 24 V	Q2			1.0	μΑ
Gate-to-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = +16 \text{ V} / -12 \text{ V}$	Q1			±100	
Current		$V_{DS} = 0 \text{ V}, V_{GS} = +16 \text{ V} / -12 \text{ V}$	Q2			±100	nA
ON CHARACTERISTICS (Note 6)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$, $I_D = 400 \mu A$	Q1	1.2		2.2	T
	V _{GS} = V _{DS} , I _D = 400 μA		Q2	1.2		2.2	·
Negative Threshold	V _{GS(TH)} /T _J	I_D = 400 μ A, ref to 25°C	Q1		-4.3		mV/°C
Temperature Coefficient		I_D = 400 μ A, ref to 25°C	Q2		-4.5		
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D = 18 A	Q1		2.0	2.5	mΩ
	-	V _{GS} = 4.5 V, I _D = 16 A			2.6	3.0	
		V _{GS} = 10 V, I _D = 18 A	Q2		1.8	2.5	
		V _{GS} = 4.5 V, I _D = 16 A			2.4	3.0	
Forward Transconductance	9FS	V _{DS} = 5 V, I _D = 18 A	Q1		129		
		V _{DS} = 5 V, I _D = 18 A	Q2		141		S
Gate-Resistance	R_{G}	T _A = 25°C	Q1		0.68		
					0.75		Ω
CHARGES, CAPACITANCES & C	SATE RESISTA	NCE					
Input Capacitance	C _{ISS}		Q1		1500		_
			Q2		1521		pF
Output Capacitance	C _{OSS}		Q1		483		
		$V_{GS} = 0 \text{ V}, V_{DS} = 15 \text{ V}, f = 1 \text{ MHz}$	Q2		498		− pF
Reverse Transfer Capacitance	C _{RSS}		Q1		29		_
			Q2		22		pF

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

6. Pulse Test: pulse width $\leq 300~\mu s$, duty cycle $\leq 2\%$.

7. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		FET	Min	Тур	Max	Unit
CHARGES, CAPACITANCES	& GATE RESIST	ANCE				•		
Total Gate Charge	Q _{G(TOT)}			Q1		9.5		
						9.3		nC
Gate-to-Drain Charge	Q_{GD}	Q1: V _{GS} = 4.5 V, V _{DS} = 15	Q1: V _{GS} = 4.5 V, V _{DS} = 15 V; I _D = 18 A			2.0		- 0
		Q2: V _{GS} = 4.5 V, V _{DS} = 19	5 V; I _D = 18 A	Q2		1.6		nC
Gate-to-Source Charge	Q_{GS}	1				3.7		0
				Q2		3.7		nC
Total Gate Charge	Q _{G(TOT)}	Q1: V _{GS} = 10 V, V _{DS} = 15	5 V; I _D = 18 A	Q1		20.8		~ C
		Q2: V _{GS} = 10 V, V _{DS} = 15	5 V; I _D = 18 A	Q2		20.5		nC
SWITCHING CHARACTERIST	ICS, VGS = 4.5	V (Note 7)						
Turn-On Delay Time	t _{d(ON)}			Q1		13		
			Ī			13.3		ns
Rise Time	t _r]		Q1		5.5		
		V _{GS} = 4.5 V		Q2		5.8		ns
Turn-Off Delay Time	t _{d(OFF)}	Q1: I_D = 18 A, V_{DD} = 15 V, R_G = 6 Ω Q2: I_D = 18 A, V_{DD} = 15 V, R_G = 6 Ω		Q1		18.9		
				Q2		19		ns
Fall Time	t _f			Q1		5.5		
				Q2		5.5		ns
SWITCHING CHARACTERIST	ICS, VGS = 10 \	/ (Note 7)						
Turn-On Delay Time	t _{d(ON)}					8.4		
				Q2		8.7		ns
Rise Time	t _r			Q1		2		
		V _{GS} = 10 V	V D 00	Q2		2		ns
Turn-Off Delay Time	t _{d(OFF)}	Q1: I _D = 18 A, V _{DD} = 15 Q2: I _D = 18 A, V _{DD} = 15		Q1		26.3		
				Q2		26.3		ns
Fall Time	t _f	1		Q1		3.8		
				Q2		3.6		ns
DRAIN-SOURCE DIODE CHA	RACTERISTICS	3						
Forward Diode Voltage	V_{SD}	$V_{GS} = 0 \text{ V},$ $T_J = 25^{\circ}\text{C}$		Q1		0.8	1.2	
		I _S = 18 A	T _J = 125°C			0.67		.,
		V _{GS} = 0 V,	T _J = 25°C	Q2		0.8	1.2	V
	I _S = 18 A T _J = 125°C			0.66				
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, V _{DD} = 15 V		Q1		30		
				Q2		29		ns
Reverse Recovery Charge	Q _{RR}	Q1: I _S = 18 A, dI _S /dt = 100 A/μs Q2: I _S = 18 A, dI _S /dt = 100 A/μs		Q1		13		
				Q2		12.5		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

6. Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.

7. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS - Q1

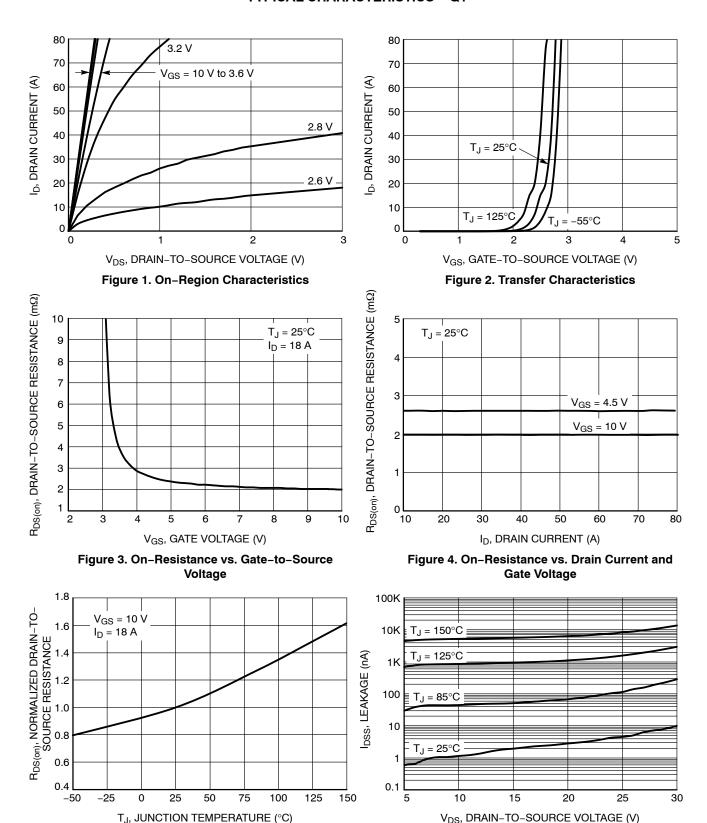


Figure 6. Drain-to-Source Leakage Current vs. Voltage

Figure 5. On-Resistance Variation with

Temperature

TYPICAL CHARACTERISTICS - Q1

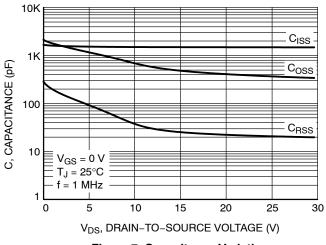


Figure 7. Capacitance Variation

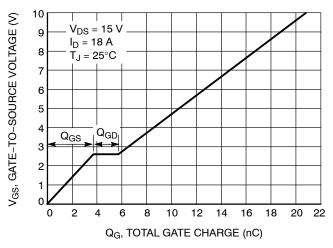


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

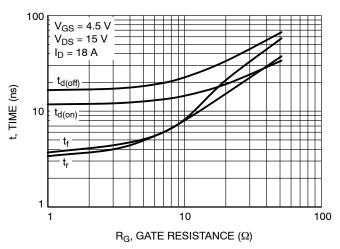


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

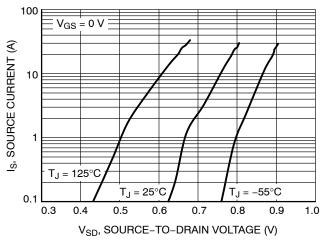


Figure 10. Diode Forward Voltage vs. Current

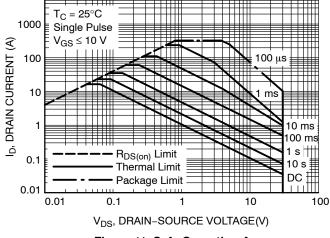


Figure 11. Safe Operating Area

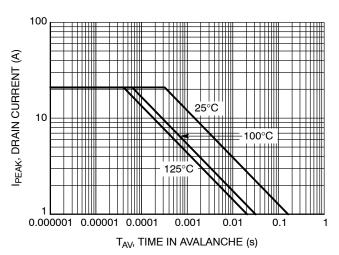


Figure 12. $I_{\mbox{\scriptsize PEAK}}$ vs. Time in Avalanche

TYPICAL CHARACTERISTICS - Q1

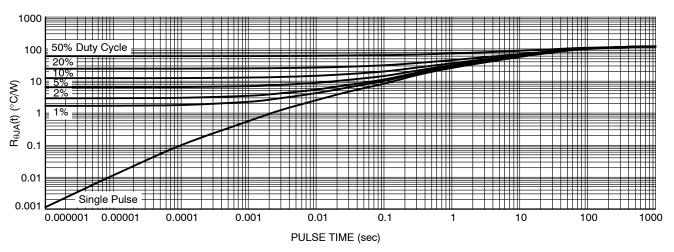


Figure 13. Thermal Characteristics

TYPICAL CHARACTERISTICS - Q2

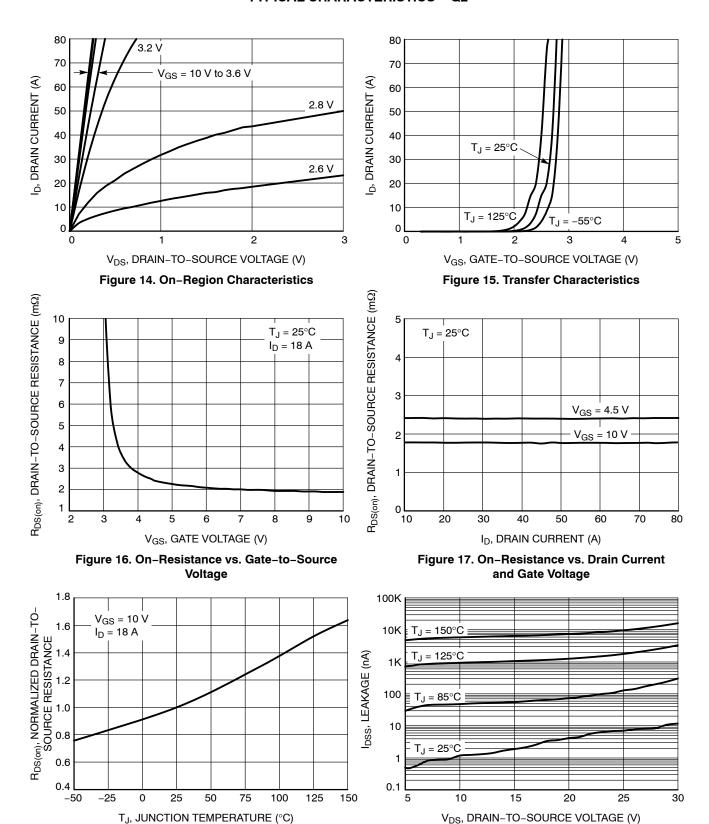


Figure 19. Drain-to-Source Leakage Current

vs. Voltage

Figure 18. On-Resistance Variation with

Temperature

TYPICAL CHARACTERISTICS - Q2

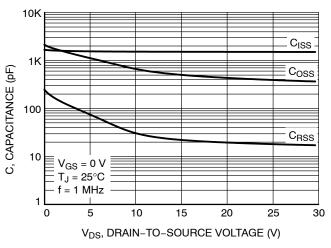


Figure 20. Capacitance Variation

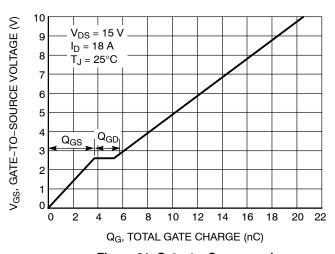


Figure 21. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

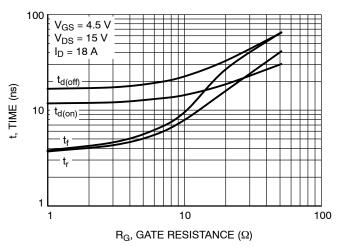


Figure 22. Resistive Switching Time Variation vs. Gate Resistance

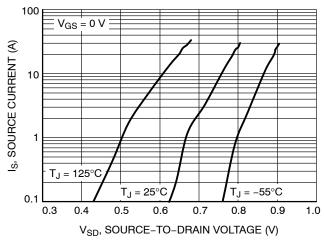


Figure 23. Diode Forward Voltage vs. Current

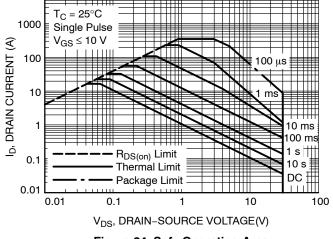


Figure 24. Safe Operating Area

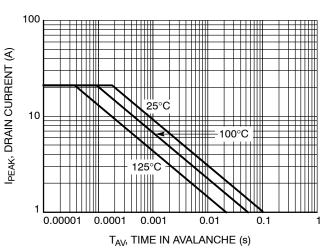


Figure 25. I_{PEAK} vs. Time in Avalanche

TYPICAL CHARACTERISTICS - Q2

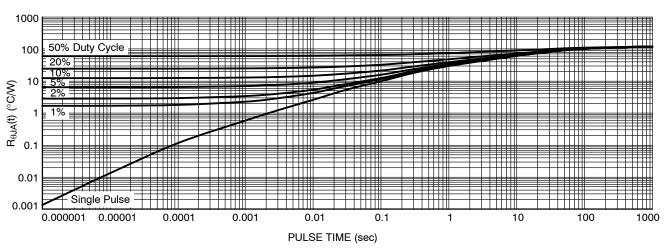


Figure 26. Thermal Characteristics

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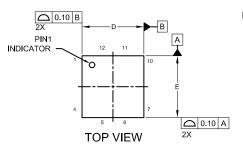




WQFN12 3.3X3.3, 0.65P

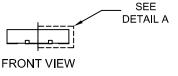
CASE 510CJ **ISSUE A**

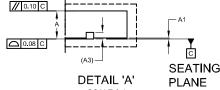
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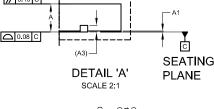


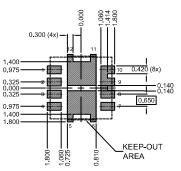
NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- CONTROLLING DIMENSION: MILLIMETERS
- 3. COPLANARITY APPLIES TO THE EXPOSED
- 4. SEATING PLANE IS DEFINED BY THE TERMINALS. "A1" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.
- 5. IT IS RECOMMENDED TO HAVE NO TRACES OR VIAS WITHIN THE KEEP OUT AREA.

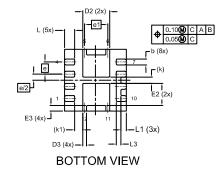








MILLIMETERS DIM NOM MIN MAX 0.70 0.75 08.0 Α 0.00 Α1 0.05 А3 0.20 REF 0.27 0.32 0.37 b D 3.20 3.30 3.40 D2 1.54 1.34 1.44 D3 0.10 0.20 0.30 Ε 3.20 3.30 3.40 E2 1.09 1.19 1.29 E3 0.20 0.30 0.40 0.65 BSC е e/2 0.325 BSC e1 1.24 BSC k 0.33 REF k1 0.43 REF L 0.44 0.54 0.64 0.19 L1 0.29 0.39 L3 0.15 0.25 0.35



GENERIC MARKING DIAGRAM*



XXXX = Specific Device Code

= Assembly Location Α

= Year WW = Work Week

= Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

1.81	8.0	AREA	
LAND	PATTE	RN	
RECO	MMEN	DATION	
*FOR ADDITION	AL INFO	DRMATION (ON OUR
PB-FREE STRAT	EGY A	ND SOLDEF	RING
DETAILS, PLEAS	SE DOW	/NLOAD TH	E ON
SEMICONDUCTO	OR SOL	DERING AN	ND
MOUNTING TEC	HNIQU	ES REFERE	NCE

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DESCRIPTION:	WQFN12 3.3X3.3, 0.65P		PAGE 1 OF 1	

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